

Notice of References Cited	Application/Control No. 10/694,187		Applicant(s)/Patent Under Reexamination CHOI, CHANG-HWAN	
	Examiner Robert G. Santos		Art Unit 3673	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0034930 A1	02-2004	Cho, Mu-Hyun	5/421
*	B	US-6,148,457	11-2000	Sul, Tae Ho	5/421
*	C	US-5,889,923	03-1999	Lee et al.	392/435
*	D	US-5,740,564	04-1998	Hankins et al.	5/12.1
*	E	US-5,550,007	08-1996	Taylor et al.	430/314
*	F	US-5,444,878	08-1995	Kang, Moo W.	5/421
*	G	US-5,430,900	07-1995	Kim, Sung-Jul	5/421
*	H	US-5,259,379	11-1993	Kim et al.	607/104
*	I	US-5,241,959	09-1993	Kim et al.	607/104
*	J	US-5,146,633	09-1992	Kim et al.	5/421
*	K	US-3,186,758	06-1965	Wanzenried, Ernest	297/118
*	L	US-2,582,555	01-1952	Miller, Edward R.	5/48
*	M	US-1,248,702	12-1917	Percival, Charles F.	5/15

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	DE 3707948 A1	09-1988	Germany	Polzer, A.	A61G 1/00
*	O	DE 3333707 A1	08-1984	Germany	Schnur, Ella	A47C 27/14
*	P	DE 2916110 A1	10-1980	Germany	Geyer, U.	A47G 9/02
*	Q	DE 2103258	08-1972	Germany	Bretz & Co.	A47C 17/14
*	R	CH 264248	01-1950	Switzerland	Litscher & Co.	5/12.1
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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